Maximum Ratings $(T_J = 25^{\circ}C \text{ unless otherwise noted})$

Rating	Symbol	Value	Unit
Peak Repetitive Off-State Voltage (Note 1) (Gate Open, Sine Wave 50 to 60 Hz, $T_J = 25$ to 125°C)	$egin{array}{c} V_{ m DRM'} \ V_{ m RRM} \end{array}$	50 100 400 600 800	V
On-State RMS Current (180° Conduction Angles; $T_c = 85$ °C	I _{T (RMS)}	25	Α
Average On-State Current (180° Conduction Angles; $T_c = 88$	I _{T (AV)}	16	А
Peak Non-repetitive Surge Current (1/2 Cycle, Sine Wave 60 Hz, T _J = 100°C)	I _{TSM}	250	А
Forward Peak Gate Power (Pulse Width \leq 1.0 μ s, T $_{\rm C}$ = 85°C)	P_{GM}	20	W
Forward Average Gate Power (t = 8.3 ms , $T_{c} = 85^{\circ}\text{C}$)	$P_{G(AV)}$	0.5	W
Forward Peak Gate Current (Pulse Width $\leq 1.0 \mu s$, $T_{\rm C} = 85^{\circ} {\rm C}$	I _{GM}	2.0	А
Operating Junction Temperature Range	T _J	-40 to +125	°C
Storage Temperature Range	T_{stg}	-40 to +150	°C

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the

Thermal Characteristics

Rating	Symbol	Value	Unit
*Thermal Resistance, Junction to Case	R _{euc}	1.5	°C/W
*Maximum Lead Temperature for Soldering Purposes, 1/8" from case for 10 seconds	T _L	260	°C

^{*} Indicates JEDEC Registered Data.

Electrical Characteristics - OFF $(T_C = 25^{\circ}C \text{ unless otherwise noted})$

Characteristic		Symbol	Min	Тур	Max	Unit
†Peak Repetitive Blocking Current	T ₁ = 25°C	I _{DRM} ,	-	-	10	μΑ
$(V_{AK} = V_{DRM} = V_{RRM}; Gate Open)$	T _J = 125°C	IRRM	-	-	2.0	mA

$\textbf{Electrical Characteristics - ON} \quad (T_{\text{C}} = 25^{\circ}\text{C unless otherwise noted}; \text{ Electricals apply in both directions})$

Characteristic			Symbol	Min	Тур	Max	Unit
* Forward On-State Voltage (Note 2) (ITM	= 50 A)		V_{TM}	-	-	1.8	V
* Gate Trigger Current (Continuous dc)		T _C = 25°C	1	_	9.0	30	mA
$(V_{AK} = 12 V_{dc'} RL = 100)$		$T_{\rm C} = -40^{\circ} \rm C$	GT	_	_	75	IIIA
* Gate Trigger Voltage (Continuous dc) ($V_{{\mbox{\tiny A}}{\mbox{\tiny B}}}$	* Gate Trigger Voltage (Continuous dc) ($V_{ak} = 12 \text{ Vdc}, R_{i} = 100 \Omega, T_{c} = -40 \text{ °C}$)			_	1.0	1.5	V
Gate Non-Trigger Voltage ($V_{AK} = 12 \text{ Vdc}, R_{L}$	$= 100 \Omega, T_{J} = 125$	5°C)	V_{gd}	0.2	-	_	V
*Holding Current ($V_D = 12 \text{ Vdc}$, $T_C = 25^{\circ}\text{C}$		1	-	18	40	mA	
		$T_{\rm C} = -40^{\circ}{\rm C}$	I _H	-	-	80	IIIA
* Turn-On Time ($I_{TM} = 25 \text{ A}, I_{GT} = 50 \text{ mAdc}$)			t _{gt}	-	1.5	2.0	μs
Turn Off Time ()/ retact voltage) $(I_{TM} = 25 \text{ A}, I_{R} =$		= 25 A)	t _q	-	15	-	μs
Turn-Off Time (V _{DRM} = rated voltage)	$(I_{TM} = 25 \text{ A}, I_{R} =$	= 25 A, T _J = 125 °C)	t _q	-	35	-	μs

^{*}Indicates JEDEC Registered Data
2. Pulse Test: Pulse Width ≤ 300 µsec, Duty Cycle ≤ 2%.



Recommended Operating Conditions may affect device reliability.

1. V_{DBM} and V_{SBM} for all types can be applied on a continuous basis. Ratings apply for zero or negative gate voltage; however, positive gate voltage shall not be applied concurrent with negative potential on the anode. Blocking voltages shall not be tested with a constant current source such that the voltage ratings of the devices are exceeded.

Dynamic Characteristics

Characteristic	Symbol	Min	Тур	Max	Unit
Critical Rate of Rise of Off-State Voltage (Gate Open, Rated $V_{\text{DRM'}}$ Exponential Waveform)	dv/dt	-	50	_	V/µs

Voltage Current Characteristic of SCR

Symbol	Parameter
V_{DRM}	Peak Repetitive Forward Off State Voltage
I _{DRM}	Peak Forward Blocking Current
V_{RRM}	Peak Repetitive Reverse Off State Voltage
I _{RRM}	Peak Reverse Blocking Current
V_{TM}	Maximum On State Voltage
l _u	Holding Current

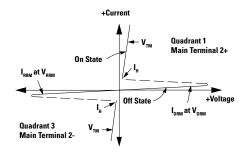


Figure 1. AverageCurrent Derating

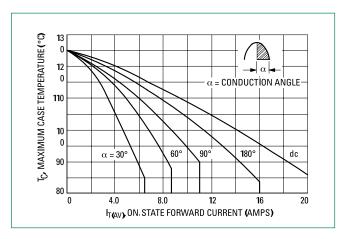


Figure 2. Maximum On-State Power Dissipation

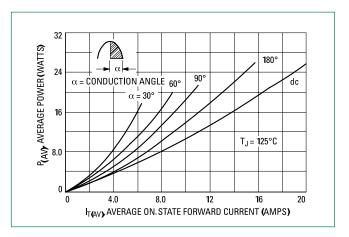


Figure 3. Typical On-State Characteristics

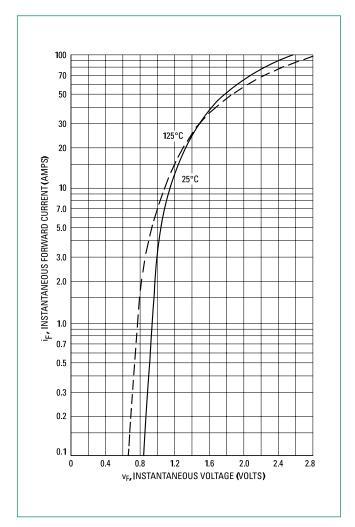


Figure 4. Maximum Non-Repetitive Surge Current

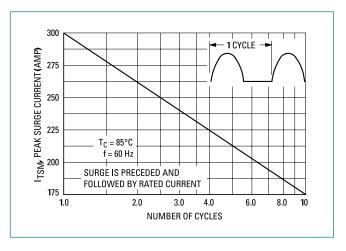
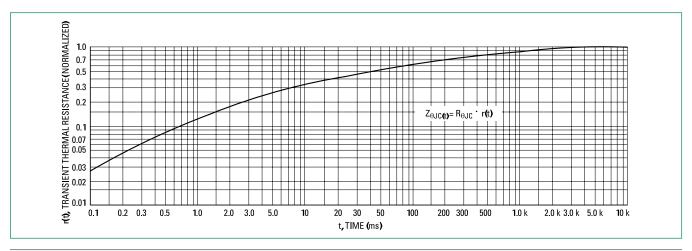


Figure 5. Thermal Response





Typical Trigger Characteristics

Figure 6. Typical Gate Trigger Current vs. Junction Temperature

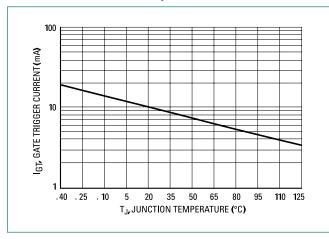


Figure 8. Typical Holding Current vs. Junction Temperature

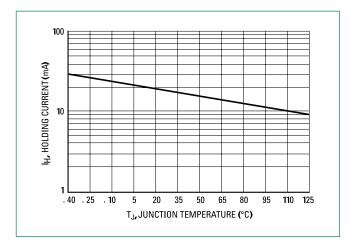
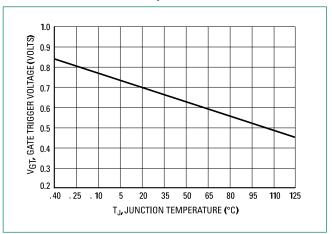
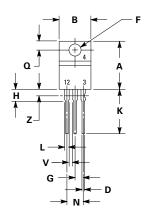


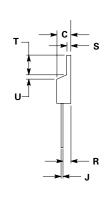
Figure 7. Typical Gate Trigger Voltage vs. Junction Temperature



2N6504 Series SCRs-25 AMPERES RMS-50 - 800V

Dimensions

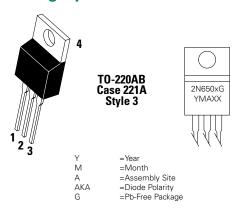




D:	Inches		Millim	neters	
Dim	Min	Max	Min	Max	
Α	0.590	0.620	14.99	15.75	
В	0.380	0.420	9.65	10.67	
С	0.178	0.188	4.52	4.78	
D	0.025	0.035	0.64	0.89	
F	0.142	0.147	3.61	3.73	
G	0.095	0.105	2.41	2.67	
Н	0.110	0.130	2.79	3.30	
J	0.018	0.024	0.46	0.61	
K	0.540	0.575	13.72	14.61	
L	0.060	0.075	1.52	1.91	
N	0.195	0.205	4.95	5.21	
Q	0.105	0.115	2.67	2.92	
R	0.085	0.095	2.16	2.41	
S	0.045	0.060	1.14	1.52	
Т	0.235	0.255	5.97	6.47	
U	0.000	0.050	0.00	1.27	
V	0.045		1.15		
Z		0.080		2.04	

- Dimensioning and tolerancing per ansi γ14.5m, 1982.
 Controlling dimension: inch.
 Dimension z defines a zone where all body and lead irregularities are allowed.

Part Marking System



Pin Assignment			
1	Cathode		
2	Anode		
3	Gate		
4	Anode		

Ordering Information

Device	Package	Shipping
2N6504	TO-220AB	
2N6504G	TO-220AB (Pb-Free)	1000 Units / Box
2N6505	TO-220AB	1000 Offits / Box
2N6505G	TO-220AB (Pb-Free)	
2N6505T	TO-220AB	
2N6505TG	TO-220AB (Pb-Free)	1000 Units / Box
2N6507	TO-220AB	
2N6507G	TO-220AB (Pb-Free)	1000 Units / Box
2N6507T	TO-220AB	
2N6507TG	TO-220AB (Pb-Free)	1000 Units / Box
2N6508	TO-220AB	
2N6508G	TO-220AB (Pb-Free)	1000 Units / Box
2N6508TG	TO-220AB	1000 Units / Box
2N6509	TO-220AB (Pb-Free)	1000 Units / Box
2N6509G	TO-220AB	·
2N6509T	TO-220AB (Pb-Free)	1000 Units / Box
2N6509TG	TO-220AB	

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